Application/Control No. 10/668,929 Applicant(s)/Patent Under Reexamination YOSHII ET AL. Examiner HOAN C. NGUYEN Applicant(s)/Patent Under Reexamination YOSHII ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*	•	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,456,336	06-1984	Chung et al.	349/160
	В	US-			
	С	US-			
	D	US-			•
	E	US-			
	F	US-			•
	G	US-			
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	Ι	US-			
	J	US-			·
	К	US-			
	L	US-			· · · · · · · · · · · · · · · · · · ·
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2002090511 A	03-2002	Japan	YONEKUBO et al.	G02B 05/08
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NON-PATENT DOCUMENTS

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